

Search Notes

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Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

FUKAGAWA ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/141-152 (limited to text search)	10/12/2006	AL
382/141-152 (limited to text search) UPDATED	1/23/2007	AL
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